


<b>Search Notes</b> 	<b>Application/Control No.</b> 10634910	<b>Applicant(s)/Patent Under Reexamination</b> BAIK, WOON-SONG
	<b>Examiner</b> Dmitry Levitan	<b>Art Unit</b> 2416

SEARCHED			
Class	Subclass	Date	Examiner
370	229, 230, 252, 310, 328, 329, 431, 437, 464, 465	3/11/09	DL
709	227-230, 238	3/11/09	DL

SEARCH NOTES		
Search Notes	Date	Examiner
IEEE, EAST	3/11/09	DL

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
370	230	3/11/09	DL

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